MSKSEMI 美森科













ESD

VS.

TSS

MOV

GDT

PIFD

2N7002ET1G-MS

Product specification





Features

- 60V,0.3A, RDS(ON) =2.2Ω@VGS=10V
- Improved dv/dt capability
- Fast switching
- Green Device Available
- G-S ESD Protection Diode Embedded
- ESD protected up to 2KV

Application

- Motor Drive
- Power Tools
- LED Lighting

BVDSS	RDSON	ID
60V	2.2Ω	0.3A

Reference News

PACKAGE OUTLINE	Pin Configuration	Marking
SOT-23	G	72K

Absolute Maximum Ratings (TA=25 ℃ unless otherwise noted)

Symbol	Parameter	Rating	Units
V _{DS}	Drain- Source Voltage	60	V
V _G s	Gate- Source Voltage	±20	V
I _D	Drain Current − Continuous (Tc=25°c)	0.3	А
טו	Drain Current – Continuous (Tc=100 °c)	0.1	А
Ірм	Drain Current – Pulsed ¹	0.8	А
Pp	Power Dissipation (T _C =25 ℃)	0.35	W
	Power Dissipation – Derate above 25 ℃	0.003	W/°C
Тѕтс	Storage Temperature Range	-50 to 150	°C
Tu	Operating Junction Temperature Range	-50 to 150	°C



Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
ReJA	Thermal Resistance Junction to ambient		357	∘c/W

Electrical Characteristics(TJ=25 °C , unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain- Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	60			V
1	Drain- Source Leakage Current	V _{DS} =60V , V _{GS} =0V , T _J =25℃			1	ŭΑ
IDSS	_	V _{DS} =48V , V _{GS} =0V , T _J =125℃			10	uА
Igss	Gate- Source Leakage Current	V _{GS-} ±20V , V _{DS} =0V			±10	uА

On Characteristics

D	Static Drain-Source On-Resistance	V _{GS} =10V , I _D =0.3A		2.2	2.8	Ω
RDS(ON)	R _{DS(ON)} Static Drain-Source On-Resistance	V _{GS} =4.5V , I _D =0.2A		2 4	3 0	Ω
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$, $I_D=250uA$	1	1.6	2.5	V
gfs	Forward Transconductance	V _{DS} =10V , I _D =0.3A		0.5		S

Dynamic and switching Characteristics

Q_g	Total Gate Charge ^{2, 3}		 3.7	5.6	
Qgs	Gate-Source Charge ² , ³	V_{DS} =30 V , V_{GS} =10 V , I_{D} =1 A	 0.9	1.4	nC
Q_{gd}	Gate-Drain Charge ^{2, 3}		 0.4	0.6	
T _{d(on)}	Turn-On Delay Time ^{2, 3}		 3	6	
Tr	Rise Time ^{2, 3}	V_{DD} =30V , V_{GS} =10V , R_{G} =6 Ω	 5	10	ns
T _{d(off)}	Turn-Off Delay Time ^{2, 3}	I _D =0.2A	 14	27	113
Tf	Fall Time ^{2, 3}		 9	17	
Ciss	Input Capacitance		 25.5	38	
Coss	Output Capacitance	V_{DS} =30 V , V_{GS} =0 V , F =1 MHz	 17	26	pF
Crss	Reverse Transfer Capacitance		 7.8	12	-

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	V _G =V _D =0V , Force Current			0.3	Α
Іѕм	Pulsed Source Current	VG-VD-0V, Force Current			1.2	Α
VsD	Diode Forward Voltage	V _{GS} =0V , I _S =1A , T _J =25℃			1.2	V
trr	Reverse Recovery Time	V_{GS} =50V, I_{S} =1A , dI/dt =100A/ μs		3.4		ns
Qrr	Reverse Recovery Charge	T _J =25℃		0.7		nC

Note:

- 1.Repetitive Rating: Pulsed width limited by maximum junction temperature.
- $2\,.$ The data tested by pulsed , pulse width $\leqq 300\,us$, duty cycle $\leqq 2\,\%\,.$
- 3. Essentially independent of operating temperature.

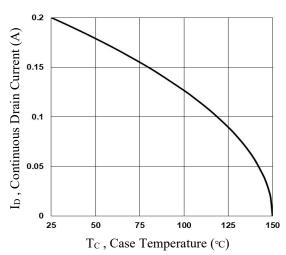


Fig.1 Continuous Drain Current vs. T_c

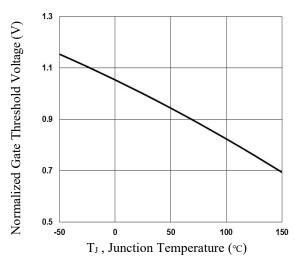


Fig.3 Normalized V_{th} vs. T_J

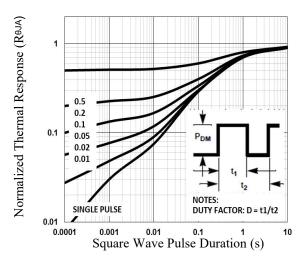


Fig.5 Normalized Transient Impedance

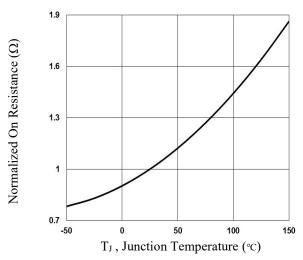


Fig.2 Normalized RDSON vs. TJ

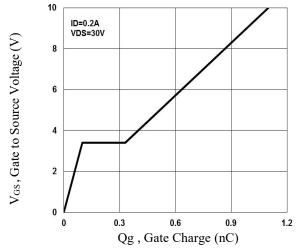


Fig.4 Gate Charge Waveform

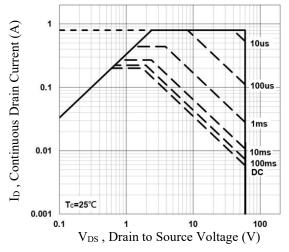
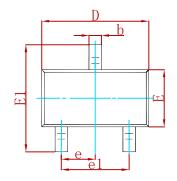
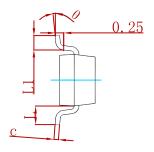


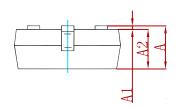
Fig.6 Maximum Safe Operation Area



PACKAGE MECHANICAL DATA

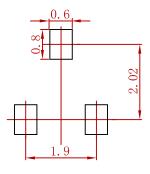






Symbol	Dimensions	Dimensions In Millimeters		ns In Inches	
Symbol	Min	Max	Min	Max	
Α	0.900	1.150	0.035	0.045	
A1	0.000	0.100	0.000	0.004	
A2	0.900	1.050	0.035	0.041	
b	0.300	0.500	0.012	0.020	
С	0.080	0.150	0.003	0.006	
D	2.800	3.000	0.110	0.118	
E	1.200	1.400	0.047	0.055	
E1	2.250	2.550	0.089	0.100	
е	0.950) TYP	0.037	7 TYP	
e1	1.800	2.000	0.071	0.079	
L	0.550 REF		0.022	2 REF	
L1	0.300	0.500	0.012	0.020	
θ	0°	8°	0°	8°	

Suggested Pad Layout



- 1.Controlling dimension:in millimeters.
- 2.General tolerance:± 0.05mm.
 3.The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
2N7002ET1G-MS	SOT-23	3000



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